Program Tentative

Technical Workshop: Combining Confocal Raman – AFM - Scanning Near Field Optical Microscopy

Date: 13th February 2020 (Thursday)

Time : 9.00 am - 3.00 pm

Venue: Auditorium B, SAINS@USM & INOR Laboratory

Time	Activity	Venue
9.00 am	Registration and breakfast	INOR foyer
9.30 am	 Session 1 Introduction to Confocal Raman Microscopy Combining Confocal Raman Microscopy with (AFM, SNOM, and SEM) 	Auditorium B, SAINS@USM
10.30	Session 2Demonstration sessionSample measurement session	INOR Characterization Lab
12.00	Lunch break	INOR foyer
1.30 pm	 Continue with sample measurement. Parallel session: Discussion/ consultation on sample for research 	INOR Characterization Lab
3.00 pm	End of session	

Notes

• The workshop is open for the participant to run Raman measurement on their samples.

• Special price for measurement:

Raman spectral measurementRaman imagingRM 50/sampleRM 80/sample

• Equipment involved: A confocal Raman imaging microscope with 532nm laser (WITec Alpha 300R)



WITec Alpha300R